

Pro Electron Series

PRO ELECTRON SERIES (Bipolar)—see page 5-37 for JFET

Type No.	Case Style	V _{CE} [*]		V _{BE} (V)	I _{CE} [*]	V _{CE} (V)	h _{FE}		V _{CE(SAT)} & V _{BE(ON)} [*]		I _C		C _{ob} (pF)	f _T		τ _{off} (ns)	NF (dB)	Test Conditions	Process No.
		Min	Max				Min	Max	Min	Max	Min	Max		Min	Max				
BC107	TO-18	50	45	6	15*	50	40 125 40	0.01 500* 0.01	5 2 5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		10	1	04
BC107A	TO-18	50	45	6	15*	50	125	260*	5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		10	1	04
BC107B	TO-18	50	45	6	15*	50	40 240	0.01 500* 2	5 5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		10	1	04
BC108	TO-18	30	20	5	15*	30	40 125	0.01 900* 2	5 5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		10	1	04
BC108A	TO-18	30	20	5	15*	30	40 125	0.01 260* 2	5 5	0.6 0.2	0.55 0.7*	100 100 2	4.5	150	10		10	1	04
BC108B	TO-18	30	20	5	15*	30	40 240	0.01 500* 2	5 5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		10	1	04
BC108C	TO-18	30	20	5	15*	30	40 450	0.01 900* 2	5 5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		10	1	04
BC109	TO-18	30	20	5	15*	30	100 240	0.01 900* 2	5 5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		4	1	04
BC109B	TO-18	30	20	5	15*	30	100 240	0.01 500* 2	5 5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		4	1	04
BC109C	TO-18	30	20	5	15*	30	100 450	0.01 900* 2	5 5	0.6 0.2	0.55 0.7*	100 10 2	4.5	150	10		4	1	04
BC140	TO-39	80*	40	7	100*	60	40	250	100*	1.0	1.8*	1A	25	50	50	850		2	14
BC140-6	TO-39	80*	40	7	100*	60	40	100	100	1.0	1.8*	1A	25	50	50	850		2	14
BC140-10	TO-39	80*	40	7	100*	60	63	160	100	1.0	1.8*	1A	25	50	50	850		2	14
BC140-16	TO-39	80*	40	7	100*	60	100	250	100	1.0	1.8*	1A	25	50	50	850		2	14
BC141	TO-39	100*	60	7	100*	60	40	250	100	1.0	1.8*	1A	25	50	50	850		2	14
BC141-6	TO-39	100*	60	7	100*	60	40	100	100	1.0	1.8*	1A	25	50	50	850		2	14
BC141-10	TO-39	100*	60	7	100*	60	63	160	100	1.0	1.8*	1A	25	50	50	850		2	14

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	VCES* VCBO (V) Min	VCEO (V) Min	VEBO (V) Min	ICES* ICBO (mA) Max	HFE I _{hfe} @ 1 kHz* Min Max	VCE(SAT) (V) Max	VBE(SAT) & VBE(ON)* (V) Min Max		IC (mA)	C _{ob} (pF) Max	f _T (MHz) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
								IC & VCE (mA) (V) Max	IC (mA) Max							
BC143	TO-5	60	60	5	50	200 2	1.5	1.5	1.5	500 200	20	60	50			63
BC146-1	TO-92 (94)	20	20	4	50	200 2 1	1.5	1.5	1.5	500 200	20	60	50			04
BC146-2	TO-92 (94)	20	20	4	50	200 2 1	1.5	1.5	1.5	500 200	20	60	50			04
BC146-3	TO-92 (94)	20	20	4	50	350 0.2 0.2	1.5	1.5	1.5	500 200	20	60	50			04
BC160	TO-39	40*	5	40	100	280 550 0.2 0.2	1.0	1.0	1.7*	1A 1A	30	50	50	650	2	67
BC160-6	TO-39	40*	5	40	100	40 100 100 1	1.0	1.0	1.7*	1A 1A	30	50	50	650	2	67
BC160-10	TO-39	40*	5	40	100	63 160 100 1	1.0	1.0	1.7*	1A 1A	30	50	50	650	2	67
BC160-16	TO-39	40*	5	40	100	100 250 100 1	1.0	1.0	1.7*	1A 1A	30	50	50	650	2	67
BC161	TO-39	60*	5	60	100	40 250 100 1	1.0	1.0	1.7*	1A 1A	30	50	50	650	2	67
BC161-6	TO-39	60*	5	60	100	40 100 100 1	1.0	1.0	1.7*	1A 1A	30	50	50	650	2	67
BC161-10	TO-39	60*	5	60	100	63 160 100 1	1.0	1.0	1.7*	1A 1A	30	50	50	650	2	67
BC161-16	TO-39	60*	5	60	100	100 250 100 1	1.0	1.0	1.7*	1A 1A	30	50	50	650	2	67
BC167	TO-92 (94)	60*	45	6	15*	110 125 500* 2 5	0.2 0.6	0.55 0.7*	10 100	4.5	150	10	10	10	1	04
BC167A	TO-92 (94)	60*	45	6	15*	110 125 260* 2 5	0.2 0.6	0.55 0.7*	10 100	4.5	150	10	10	10	1	04
BC167B	TO-92 (94)	60*	45	6	15*	110 240 500* 2 5	0.2 0.6	0.55 0.7*	10 100	4.5	150	10	10	10	1	04
BC168	TO-92 (94)		20	5	15*	110 125 900* 2 5	0.2 0.6	0.55 0.70*	10 100	4.5	150	10	10	10	1	04
BC168A	TO-92 (94)		20	5	15*	110 125 260* 2 5	0.2 0.6	0.55 0.70*	10 100	4.5	150	10	10	10	1	04
BC168B	TO-92 (94)		20	5	15*	110 240 500* 2 5	0.2 0.6	0.55 0.70*	10 100	4.5	150	10	10	10	1	04

T-29-01

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.



Pro Electron Series

Pro Electron Series

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} [*] I _{CB0} (mA) Max	H _{FE} h _{FE} @ 1 kHz Min Max	I _C & V _{CE} (mA) (V) Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max	I _C (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC168C	TO-92 (94)		20	5	15*	110 450	2 900*	0.2 0.6	0.55 0.70*	10 100	4.5	150	10		10	1	04
BC169	TO-92 (94)		20	5	15*	110 240	2 900*	0.2 0.6	0.55 0.70*	10 100	4.5	150	10		4	1	04
BC169B	TO-92 (94)		20	5	15*	110 240	2 500*	0.2 0.6	0.55 0.70*	10 100	4.5	150	10		4	1	04
BC168C	TO-92 (94)		20	5	15*	110 450	2 900*	0.2 0.6	0.55 0.70*	10 100	4.5	150	10		4	1	04
BC177	TO-18	50	45	5	100	110 125	2 500*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		10	1	71
BC177A	TO-18	50	45	5	100	110 125	2 260*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		10	1	71
BC177B	TO-18	50	45	5	100	110 240	2 500*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		10	1	71
BC177VI	TO-18	50	45	5	100	110 75	2 150*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		10	1	71
BC178	TO-18	30	25	5	100	110 125	2 900*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		10	1	71
BC178A	TO-18	30	25	5	100	110 125	2 260*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		10	1	71
BC178B	TO-18	30	25	5	100	110 240	2 500*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		10	1	71
BC179	TO-18	25	20	5	100	110 125	2 900*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		4	1	71
BC179A	TO-18	25	20	5	100	110 125	2 260*	0.18	0.78 0.75* 1.0*	10 100	4.5	150	10		4	1	71

T-29-01

6501130 NATL SEMICOND, (DISCRETE)

28C 35514

T-29-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE5} [*] V _{CE0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} [*] I _{CB0} (mA) Max	HFE h _{FE} 1 kHz [*] Min Max	I _C & V _{CE} (mA) (V) Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(OH)} [*] (V) Min Max	I _C (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC179B	TO-18	25	20	5	100	20	2	0.18	0.78	10	4.5	150		4	1	71
BC182	TO-92 (97)	60	50	5	15	40	0.01	0.6	1.2	10	5	150		10	1	04
BC182A	TO-92 (97)	60	50	5	15	125	2	0.25	0.55	10	5	150		10	1	04
BC182B	TO-92 (97)	60	50	5	15	40	0.01	0.6	1.2	10	5	150		10	1	04
BC182L	TO-92 (94)	60	50	5	15	80	100	0.25	0.55	10	5	150		10	1	04
BC182LA	TO-92 (94)	60	50	5	15	125	2	0.25	0.55	10	5	150		10	1	04
BC182LB	TO-92 (94)	60	50	5	15	80	100	0.25	0.55	10	5	150		10	1	04
BC183	TO-92 (97)	45	30	5	15	40	0.01	0.6	1.2	10	5	150		10	1	04
BC183A	TO-92 (97)	45	30	5	15	125	2	0.25	0.55	10	5	150		10	1	04
BC183B	TO-92 (97)	45	30	5	15	40	0.01	0.6	1.2	10	5	150		10	1	04
BC183C	TO-92 (97)	45	30	5	15	80	100	0.25	0.55	10	5	150		10	1	04

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

5

Pro Electron Series

T-29-01



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Min	V _{EB0} (V) Min	I _{CE0} [*] (mA) Max	V _{CB} (V)	HFE h _{FE} 1 kHz [*] Min	I _C & V _{CE} (mA) (V) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.		
										I _C (mA) Min	V _{BE(SAT)} (V) Min									V _{BE(ON)} [*] (V) Max	
BC183L	TO-92 (94)	30	30	5	15	30	40	0.01 5	0.6	1.2	100	5	150	10			10	1		04	
BC183LA	TO-92 (94)	30	30	5	15	30	125	900* 2 5	0.25	0.70* 2	10	5	150	10			10	1		04	
							80	260* 2 5	0.25	0.70* 2	10										
BC183LB	TO-92 (94)	30	30	5	15	30	125	900* 2 5	0.25	0.70* 2	10	5	150	10			10	1		04	
							80	500* 2 5	0.25	0.70* 2	10										
BC183LC	TO-92 (94)	30	30	5	15	30	40	0.01 5	0.6	1.2	100	5	150	10			10	1		04	
							80	900* 2 5	0.25	0.70* 2	10										
BC184	TO-92 (97)	30	30	5	15	30	100	0.01 5	0.6	1.2	100	5	150	10			10	4	1	04	
							130	900* 2 5	0.25	0.70* 2	10										
BC184B	TO-92 (97)	30	30	5	15	30	100	0.01 5	0.6	1.2	100	5	150	10			10	4	1	04	
							130	500* 2 5	0.25	0.70* 2	10										
BC184C	TO-92 (97)	30	30	50	15	30	100	0.01 5	0.6	1.2	100	5	150	10			10	4	1	04	
							130	900* 2 5	0.25	0.70* 2	10										
BC184L	TO-92 (94)	30	30	50	15	30	100	0.01 5	0.6	1.2	100	5	150	10			10	4	1	04	
							130	900* 2 5	0.25	0.70* 2	10										
BC184LB	TO-92 (94)	30	30	50	15	30	100	0.01 5	0.6	1.2	100	5	150	10			10	4	1	04	
							130	500* 2 5	0.25	0.70* 2	10										
BC184LC	TO-92 (94)	30	30	50	15	30	100	0.01 5	0.6	1.2	100	5	150	10			10	4	1	04	
							130	900* 2 5	0.25	0.70* 2	10										
BC204	TO-92 (92)	45	45	5	50	45	50	450 2 5	0.3		10						10	1		71	
BC207	TO-92 (92)	45	45	5	15	40	110	450 2 5	0.25		10	6						10	1		04
							450	900* 2 5	0.6	100											
BC212	TO-92 (97)	50	50	5	15	30	60	400* 2 5	0.6	1.1	100	10						10	1		63
							450	900* 2 5	0.25	100	0.6										

6501130 NATL SEMICOND, (DISCRETE)

28C 35516

T-29-01

Pro Electron Series

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE5} [*] (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE5} [*] (mA) Max	I _{CB0} (mA) Max	HFE h _{FE} 1 kHz [*] Min	I _C & V _{CE} (mA) & (V) Min	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V)		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
										Min	Max								
BC212A	TO-92 (97)	60	50	5	15	30	100	300* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC212B	TO-92 (97)	60	50	5	15	30	200	400* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC212L	TO-92 (94)	60	50	5	15	30	40	300 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC212LA	TO-92 (94)	60	50	5	15	30	60*	300 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC212LB	TO-92 (94)	60	50	5	15	30	40	400* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC213	TO-92 (97)	45	30	5	15	30	60	600* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC213A	TO-92 (97)	45	30	5	15	30	80	400* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC213B	TO-92 (97)	45	30	5	15	30	100	300* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC213C	TO-92 (97)	45	30	5	15	30	40	400* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC213L	TO-92 (94)	45	30	5	15	30	350	600* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC213LA	TO-92 (94)	45	30	5	15	30	80*	400 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			
BC213LB	TO-92 (94)	45	30	5	15	30	100	300* 2	0.6 0.25	1.1 0.6	100 10	10	200	10	1	63			

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = 50 kHz.

5

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35517 D

T-29-01

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CEO} (V) Min	V _{EB} (V) Min	I _{CB} [*] I _{BO} (mA) Max	V _{CB} (V)	HFE		I _C & V _{CE} (mA) & (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} (V)		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
							Min	Max			Min	Max								
BC213LB	TO-92 (94)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC213LC	TO-92 (94)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC214	TO-92 (97)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC214A	TO-92 (97)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC214B	TO-92 (97)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC214C	TO-92 (97)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC214L	TO-92 (94)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC214LB	TO-92 (94)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC214LC	TO-92 (94)	45	30	5	15	30	40	0.01	5	0.6	1.1	100	10	10	200	10			1	63
BC237-92	TO-92 (97)	50	45	6	50	20	100	0.01	5	0.25	0.6	0.72*	10	4.5				10	1	04
BC237A-92	TO-92 (97)	50	45	6	50	20	100	0.01	5	0.25	0.6	0.72*	10	4.5				10	1	04

6501130 NATL SEMICOND, (DISCRETE)

28C 35518

T-24-01

D

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE5} [*] (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE5} [*] (mA) Max	I _{CB0} (mA) Max	V _{CB} (V) Max	h _{FE} @ 1 kHz [*]		I _C (mA) & V _{CE} (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V)		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Mfin Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
								Min	Max			Min	Max							
BC237B-92	TO-92 (97)	50	45	6	50	20	20	100 140 120 240	0.01 2 100 500*	5 5 5 5	0.25	0.77* 0.6	10 100	4.5				10	1	04
BC238-92	TO-92 (97)	30	20	5	50	20	20	100 140 120 125	0.01 2 100 900*	5 5 5 5	0.25	0.77* 0.6	10 100 2	4.5				10	1	04
BC238A-92	TO-92 (97)	30	20	5	50	20	20	100 140 120 125	0.01 2 100 260*	5 5 5 5	0.25	0.77* 0.6	10 100 2	4.5				10	1	04
BC238B-92	TO-92 (97)	30	20	5	50	20	20	100 140 120 240	0.01 2 100 500*	5 5 5 5	0.25	0.77* 0.6	10 100 2	4.5				10	1	04
BC238C-92	TO-92 (97)	30	20	5	50	20	20	100 140 120 450	0.01 2 100 900*	5 5 5 5	0.25	0.77* 0.6	10 100 2	4.5				10	1	04
BC239-92	TO-92 (97)	30	20	5	50	20	20	100 140 120 240	0.01 2 100 900*	5 5 5 5	0.25	0.77* 0.6	10 100 2	4.5				4	1	04
BC239B-92	TO-92 (97)	30	20	5	50	20	20	100 140 120 240	0.01 2 100 500*	5 5 5 5	0.25	0.77* 0.6	10 100 2	4.5				4	1	04
BC239C-92	TO-92 (97)	30	20	5	50	20	20	100 140 120 450	0.01 2 100 900*	5 5 5 5	0.25	0.77* 0.6	10 100 2	4.5				4	1	04
BC261A	TO-18		45		50	45	45	100 140 120 125	0.01 2 100 260*	5 5 5 5	0.25 0.6	0.9 0.9	10 100	4.5				6	3	71

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

5

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35519 D
T-29-01

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] VCBO (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} [*] ICBO (mA) Max	H _{FE} I _{FE} @ 1 kHz Min	I _C & V _{CE} (mA) & (V) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} (V)		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
									Mfn	Mfn								
BC261B	TO-18		45		50	100	0.01 5 2 5 100 5 500* 2 5	0.25 0.6	0.9	10						6	3	71
BC262A	TO-18		20	5	50	100	0.01 5 2 5 120 100 5 260* 2 5	0.25	0.9	10						6	3	71
BC262B	TO-18		20	5	50	100	0.01 5 2 5 120 100 5 500* 2 5	0.25	0.9	10						6	3	71
BC263A	TO-18		20	5	50	100	0.01 5 2 5 120 100 5 260* 2 5	0.25	0.9	10						2.5	3	71
BC263B	TO-18		20	5	50	100	0.01 5 2 5 120 100 5 500* 2 5	0.25	0.9	10						2.5	3	71
BC307-92	TO-92 (97)		45	5	100	100	0.01 5 2 5 120 100 5 500* 2 5	0.18	0.78 1.0*	10 100						10	1	71
BC307A-92	TO-92 (97)		45	5	100	100	0.01 5 2 5 120 100 5 260* 2 5	0.18	0.78 1.0*	10 100						10	1	71
BC307B-92	TO-92 (97)		45	5	100	100	0.01 5 2 5 120 100 5 500* 2 5	0.18	0.78 1.0*	10 100						10	1	71
BC308-92	TO-92 (97)		25	5	100	100	0.01 5 2 5 120 100 5 900* 2 5	0.18	0.78 1.0*	10 100						10	1	71
BC308A-92	TO-92 (97)		25	5	100	100	0.01 5 2 5 120 100 5 260* 2 5	0.18	0.78 1.0*	10 100						10	1	71

6501130 NATL SEMICOND, (DISCRETE)

28C 35520

T-29-01

D

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} ^s V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} ^s I _{CB0} (mA) Max	I _C & V _{CE} @ (mA) (V) Min Max	V _{CE} (SAT) (V) Max	V _{BE} (SAT) & V _{BE} (ON) [*] (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC308B-92	TO-92 (97)	30	25	5	100	0.01 5 400 2 5 120 100 5 240 500* 2 5	0.18	0.78 10 1.0* 100	10					10	1	71
BC308C-92	TO-92 (97)	30	25	5	100	0.01 5 400 2 5 120 100 5 450 900* 2 5	0.18	0.78 10 1.0* 100	10					10	1	71
BC309-92	TO-92 (97)	25	20	5	100	0.01 5 400 2 5 120 100 5 125 900* 2 5	0.18	0.78 10 1.0 100	10					4	1	71
BC309B-92	TO-92 (97)	25	20	5	100	0.01 5 400 2 5 120 100 5 240 500* 2 5	0.18	0.78 10 1.0 100	10					4	1	71
BC309C-92	TO-92 (97)	25	20	5	100	0.01 5 400 2 5 120 100 5 450 900* 2 5	0.8	0.78 10 1.0 100	10					4	1	71
BC317	TO-92 (92)	50	45	6	30	2 5 450 2 5 500* 2 5	0.2 0.5	0.77* 10 0.57 0.72* 2	10	4				6	1	04
BC317A	TO-92 (92)	50	45	6	30	2 5 450 2 5 500* 2 5	0.2 0.5	0.77* 10 0.57 0.72* 2	10	4				6	1	04
BC317B	TO-92 (92)	50	45	6	30	2 5 450 2 5 500* 2 5	0.2 0.5	0.77* 10 0.57 0.72* 2	10	4				6	1	04
BC318	TO-92 (92)	30	20	5	30	2 5 800 2 5 900* 2 5	0.2 0.5	0.77* 10 0.57 0.72* 2	10	4				6	1	04
BC318A	TO-92 (92)	30	20	5	30	2 5 800 2 5 900* 2 5	0.2 0.5	0.77* 10 0.57 0.72* 2	10	4				6	1	04

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

5

T-29-01

Pro Electron Series

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} [*] I _{CB0} (mA) Max	V _{CB} (V)	HFE h _{FE} @ 1 kHz Min Max	I _C & V _{CE} I _C (mA) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.	
BC318B	TO-92 (92)	30	20	5	30	20	200 240	450 500*	2 2	5 5	0.2 0.5	0.77* 100	4			6	1	04
BC318C	TO-92 (92)	30	20	5	30	20	100 450	800 900*	2 2	5 5	0.2 0.5	0.77* 100	4			6	1	04
BC319	TO-92 (92)	30	20	5	30	20	40 200	800 900*	2 2	5 5	0.2 0.5	0.77* 100	4			4	1	04
BC319B	TO-92 (92)	30	20	5	30	20	200 240	450 500*	2 2	5 5	0.2 0.5	0.77* 100	4			4	1	04
BC319C	TO-92 (92)	30	20	5	30	20	100 420	800 900*	2 2	5 5	0.2 0.5	0.77* 100	4			4	1	04
BC327	TO-92 (97)	50†	45	5	100†	45	40 100	300 600	1 1	1	0.7	500 300	4			4	1	67
BC327-10	TO-92 (97)	50†	45	5	100†	45	40 63	300 160	1 1	1	0.7	500 300	4			4	1	67
BC327-16	TO-92 (97)	50†	45	5	100†	45	40 100	300 250	1 1	1	0.7	500 300	4			4	1	67
BC327-25	TO-92 (97)	50†	45	5	100†	45	40 160	300 400	1 1	1	0.7	500 300	4			4	1	67
BC328	TO-92 (97)	30†	25	5	100†	25	40 100	300 600	1 1	1	0.7	500 300	4			4	1	67
BC328-10	TO-92 (97)	30†	25	5	100†	25	40 63	300 160	1 1	1	0.7	500 300	4			4	1	67
BC328-16	TO-92 (97)	30†	25	5	100†	25	40 100	300 250	1 1	1	0.7	500 300	4			4	1	67
BC328-25	TO-92 (97)	30†	25	5	100†	25	40 160	300 400	1 1	1	0.7	500 300	4			4	1	67
BC337	TO-92 (97)	50†	45	5	100†	45	40 100	300 600	1 1	1	0.7	500 300	4			4	1	14
BC337-10	TO-92 (97)	50†	45	5	100†	45	40 63	300 160	1 1	1	0.7	500 300	4			4	1	14
BC337-16	TO-92 (97)	50†	45	5	100†	45	40 100	300 250	1 1	1	0.7	500 300	4			4	1	14
BC337-25	TO-92 (97)	50†	45	5	100†	45	40 160	300 400	1 1	1	0.7	500 300	4			4	1	14

T-29-01

D

Pro Electron Series

5

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	VCES* VCBO Min	VCEO (V) Min	VEBO (V) Min	ICES* ICBO @ (mA) Max	V _{CB} (V)	HFE h _{fe} 1 kHz		VCE(SAT) & VCE		VCE(SAT) (V) Max	VBE(SAT) & VBE(ON)* (V)		Cob (pF) Max	f _T (MHz)		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
							Min	Max	IC (mA)	VCE (V)		Min	Max		Min	Max				
BC338	TO-92 (97)	30†	25	5	100†	25	40	300	1	0.7	500	1.2*	4						1	14
BC338-10	TO-92 (97)	30†	25	5	100†	25	40	300	1	0.7	500	1.2*	4						1	14
BC338-16	TO-92 (97)	30†	25	5	100†	25	63	160	1	0.7	500	1.2*	4						1	14
BC338-25	TO-92 (97)	30†	25	5	100†	25	40	250	1	0.7	500	1.2*	4						1	14
BC415	TO-92 (97)	45	35	5	15	30	40	400	1	0.25	10	1.2*	4						1	14
BC415A	TO-92 (97)	45	35	5	15	30	120	800	2	0.6	100	1.2*	2						10	71
BC415B	TO-92 (97)	45	35	5	15	30	40	220	2	0.6	100	1.2*	2						10	71
BC415C	TO-92 (97)	45	35	5	15	30	100	460	2	0.6	100	1.2*	2						10	71
BC485	TO-92 (97)	45	45	5	100	30	15	1A	5	0.5	500	1.2*	4						1	14
BC485A	TO-92 (97)	45	45	5	100	30	40	10	2	0.5	300	1.2*	4						1	14
BC485B	TO-92 (97)	45	45	5	100	30	15	1A	5	0.5	500	1.2*	4						1	14
BC485L	TO-92 (97)	45	45	5	100	30	40	10	2	0.5	300	1.2*	4						1	14
BC547	TO-92 (97)	50	45	6	10	20	125	500*	2	0.25	10	0.77*	10	4.5					1	04
BC547A	TO-92 (97)	50	45	6	10	20	125	260*	2	0.6	100	0.77*	10	4.5					1	04

TEST CONDITIONS:
 (1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35523 D

T-29-01

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] V _{CEO} (V) Min	V _{CE} [*] V _{CEO} (V) Max	V _{BE} (V) Min	V _{BE} (V) Max	I _{CEO} [*] I _{CEO} (mA) Min	I _{CEO} [*] I _{CEO} (mA) Max	HFE h _{FE} 1 kHz	I _C & V _{CE} (mA) (V) Min	I _C & V _{CE} (mA) (V) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Max	I _C (mA) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC547B	TO-92 (97)	50	45	6	20	10	10	240	500* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				10	1	04
BC547C	TO-92 (97)	50	45	6	20	10	10	450	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				10	1	04
BC548	TO-92 (97)	30	20	5	20	10	10	125	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				10	1	04
BC548A	TO-92 (97)	30	20	5	20	10	10	125	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				10	1	04
BC548B	TO-92 (97)	30	20	5	20	10	10	240	500* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				10	1	04
BC548C	TO-92 (97)	30	20	5	20	10	10	450	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				10	1	04
BC549	TO-92 (97)	30	20	5	20	10	10	240	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				4	1	04
BC549B	TO-92 (97)	30	20	5	20	10	10	240	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				4	1	04
BC549C	TO-92 (97)	30	20	5	20	10	10	450	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2	4.5				4	1	04
BC550	TO-92 (97)	50	45	5	45	10	10	240	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2					3	1	04
BC550B	TO-92 (97)	50	45	5	45	10	10	240	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2					3	1	04
BC550C	TO-92 (97)	50	45	5	45	10	10	450	900* 2	5	0.25 0.6	0.77* 0.55	0.77* 0.70*	10 100	2					3	1	04
BC557	TO-92 (97)	50	45	5	20	100	100	75	260* 2	5	0.3 0.65	0.82* 0.6	0.82* 0.75*	10 100	2					10	1	71

6501130 NATL SEMICOND, (DISCRETE)

28C 35524

T-29-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE5} [*] V _{CE0} (V) Min	V _{CE0} (V) Min	V _{BE0} (V) Min	I _{CE5} [*] I _{CE0} (mA) Max	HFE h _{FE} @ 1 kHz Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC557A	TO-92 (97)	50	45	5	100	20	0.3 0.65	0.82* 0.75* 2	10 100				10	1	71
BC557B	TO-92 (97)	50	45	5	100	20	0.3 0.65	0.82* 0.75* 2	10 100				10	1	71
BC558	TO-92 (97)	30	25	5	100	20	0.3 0.65	0.82* 0.75* 2	10 100				10	1	71
BC558A	TO-92 (97)	30	25	5	100	20	0.3 0.65	0.82* 0.75 2	10 100				10	1	71
BC558B	TO-92 (97)	30	25	5	100	20	0.3 0.65	0.82* 0.75 2	10 100				10	1	71
BC558C	TO-92 (97)	30	25	5	100	20	0.3 0.65	0.82* 0.75 2	10 100				10	1	71
BC559	TO-92 (97)	25	20	5	100	20	0.3 0.65	0.82* 0.75* 2	10 100				4	1	71
BC559A	TO-92 (97)	25	20	5	100	20	0.3 0.65	0.82* 0.75* 2	10 100				4	1	71
BC559B	TO-92 (97)	25	20	5	100	20	0.3 0.65	0.82* 0.75* 2	10 100				4	1	71
BC559C	TO-92 (97)	25	20	5	100	20	0.3 0.65	0.82* 0.75* 2	10 100				4	1	71
BC560	TO-92 (97)	50	45	5	100	45	0.3 0.65	0.82* 0.75* 2	10 100				2	1	71

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

5

Pro Electron Series

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35525

D

T-29-01



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} * V _{CE0} (V) Min	V _{BE0} (V) Min	I _{CE} * I _{CB0} @ (mA) Max	H _{FE} h _{FE} 1 kHz* Min Max	I _C & V _{CE} (mA) & (V)	V _{CE} (SAT) (V) Max	V _{BE} (SAT) (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BC560A	TO-92 (97)	45	5	100	125 260*	2 5	0.3, 0.65	0.82* 0.6	10 2					2	1	71
BC560B	TO-92 (97)	45	5	100	240 500*	2 5	0.3 0.65	0.82* 0.6	10 2					2	1	71
BC560C	TO-92 (97)	45	5	100	450 900*	2 5	0.3 0.65	0.82* 0.6	10 2					2	1	71
BCX58	TO-92 (97)	32	7	10	120 630 80 1000	2 5 10 1					125	10	800	6	3/4	04
BCX58-7	TO-92 (97)	32	7	10	120 220 80 100	2 5 10 1					125	10	800	6	3/4	04
BCX58-8	TO-92 (97)	32	7	10	20 310 120 400	0.01 5 10 1					125	10	800	6	3/4	04
BCX58-9	TO-92 (97)	32	7	10	40 400 250 460 160 630 60	0.01 5 2 5 10 1 100 1					125	10	800	6	3/4	04
BCX58-10	TO-92 (97)	32	7	10	100 380 240 1000 60	0.01 5 2 5 10 1 100 1					125	10	800	6	3/4	04
BCX59	TO-92 (97)	45	7		120 630 80 1000 40	2 5 10 1 100 1	0.5	1.0	100		125	10	800		5	04
BCX59-7	TO-92 (97)	45	7		120 220 80 1000 40	2 5 10 1 100 1	0.5	1.0	100		125	10	800		5	04
BCX59-8	TO-92 (97)	45	7		20 310 180 400 45	0.01 5 10 1 100 1	0.5	1.0	100		125	10	800		5	04
BCX59-9	TO-92 (97)	45	7		40 250 250 460 160 630 60	0.01 5 2 5 10 1 100 1	0.5	1.0	100		125	10	800		5	04

6501130 NATL SEMICOND, (DISCRETE)

28C 35526

D

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EBO} (V) Min	I _{CS} [*] I _{CB0} (nA) Max	HFE I _{hfe} @ 1 kHz [*] Min Max	I _C & V _{CE} (mA) & (V)	V _{CE(SAT)} & V _{BE(ON)} [*] (V) & (V)		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
								Max	Min								
BCX59-10	TO-92 (97)		45	7		100 380 240 60	0.01 2 10 100	5 5 1 1	0.5	1.0	100		10	800		5	04
BCX78	TO-92 (97)		32	5		120 80 40	2 10 100	5 1 1	0.6	1.0	100						71
BCX78-7	TO-92 (97)		32	5		120 80 40	2 10 100	5 1 1	0.6	1.0	100						71
BCX78-8	TO-92 (97)		32	5		30 180 120 45	0.01 2 10 100	5 5 1 1	0.6	1.0	100						71
BCX78-9	TO-92 (97)		32	5		40 250 160 60	0.01 2 10 100	5 5 1 1	0.6	1.0	100						71
BCX78-10	TO-92 (97)		32	5		100 380 240 60	0.01 2 10 100	5 5 1 1	0.6	1.0	100						71
BCX79	TO-92 (97)		45	5		80 40	1000 100	1 1	0.6	1.0	100						71
BCX79-7	TO-92 (97)		45	5		120 60	2 100	5 1	0.6	1.0	100						71
BCX79-8	TO-92 (97)		45	5		120 45	2 100	5 1	0.6	1.0	100						71
BCX79-9	TO-92 (97)		45	5		160 60 40	10 100 0.01	1 1 5	0.6	1.0	100						71

T-29-01

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

5

Pro Electron Series

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35527 D

T-29-01

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE(S)} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CS} [*] (mA) Max	I _{CS0} [*] (mA) Max	HFE h _{FE} 1 kHz [*]	I _C & V _{CE} (mA) & (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(OH)} [*] (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BCX79-10	TO-92 (97)		45	5			240 60 100 380	1000 100 0.01 5	0.6	1.0	100							71
BCY56	TO-18	45	45	5	100	20	40 100 125 40	10 2 500* 5	0.6	0.7*	2					5	1	04
BCY57	TO-18	25	20	5	100	20	200 200 240 100	10 2 5 0.01	0.6	0.7*	2					5	1	04
BCY58	TO-18		32	7	10 [†]	32	40 80 125	100 10 2	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04
BCY58-7	TO-18		32	7	10 [†]	32	40 80 125	100 10 2	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04
BCY58-8	TO-18		32	7	10 [†]	32	40 80 175	100 10 350*	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04
BCY58-9	TO-18		32	7	10 [†]	32	40 80 250	100 10 500*	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04
BCY58-10	TO-18		32	7	10 [†]	32	40 80 350	100 10 700*	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04
BCY59	TO-18		45	7	10 [†]	45	40 80 125	100 10 2	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04
BCY59-7	TO-18		45	7	10 [†]	45	40 80 125	100 10 2	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04
BCY59-8	TO-18		45	7	10 [†]	45	40 80 175	100 10 350*	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04
BCY59-9	TO-18		45	7	10 [†]	45	40 80 250	100 10 500*	0.35 0.7	0.85 1.2	10 100	6	125	10	800	6	4/1	04

6501130 NATL SEMICOND, (DISCRETE)

28C 35528

D

T-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} (V) Min	V _{EB} (V) Min	I _{CE} [*] I _{CB} (mA) Max	H _{FE} h _{FE} @ 1 kHz Min Max	I _C & V _{CE} (mA) (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BCY59-10	TO-18		45	7	10 ¹	40 80 350	100 10 700	0.35 0.7	0.6 0.75 0.55	10 1.2 0.7	6	125	10	800	6	4/1	04
BCY70	TO-18		40	5	10	40 45 50 15	0.1 1 10 50	0.25	0.6 0.9	10	6	250	10	420	6	5/6	71
BCY71	TO-18	45	45	5	500	40 80 90 100	0.01 0.1 1 600	0.25	0.6 0.9 1.2	10	6	200	10		2	6	71
BCY71A	TO-18	45	45	5	500	40 80 90 100	0.01 0.1 1 600	0.25	0.6 0.9	10	6	300	10	420	2	6	71
BCY72	TO-18	25	25	5	500	40 50	1 10	0.25 0.5	0.6 0.9	10	6	200	10	420	6	5/6	71
BD135	TO-126	45	45	5	100	25 40	500 250	0.5	1.0*	500		50	50	420	6	5/6	37
BD135-6	TO-126	45	45	5	100	40 25	150 500	0.5		500		50	50				37
BD135-10	TO-126	45	45	5	100	63 25	160 500	0.5		500		50	50				37
BD135-16	TO-126	45	45	5	100	100 25	150 500	0.5		500		50	50				37
BD136	TO-126	45	45	5	100	40 25	150 500	0.5		500		50	50				77
BD136-6	TO-126	45	45	5	100	40 25	150 500	0.5		500		50	50				77
BD136-10	TO-126	45	45	5	100	63 25	160 500	0.5		500		50	50				77
BD136-16	TO-126	45	45	5	100	100 25	150 500	0.5		500		50	50				77
BD137	TO-126	60	60	5	100	40 25	150 500	0.5		500		50	50				38

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 μA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

ro Electron Series

5

Pro Electron Series

6501130 NATL SEMICOND, (DISCRETE)

28C 35529 D

T-33-01

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} * V _{CE0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} * I _{CB0} (mA) Max	HFE h _{FE} 1 kHz* Min Max	I _C & V _{CE} (mA) (V) 2 2	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} * (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD137-6	TO-126	60	60	5	100	40 100	150 2	0.5		500		50	50				38
BD137-10	TO-126	60	60	5	100	63 160	150 2	0.5		500		50	50				38
BD138	TO-126	60	60	5	100	40 160	150 2	0.5		500		50	50				78
BD138-6	TO-126	60	60	5	100	40 100	150 2	0.5		500		50	50				78
BD138-10	TO-126	60	60	5	100	63 160	150 2	0.5		500		50	50				78
BD139	TO-126	80	80	5	100	25 500	500 2	0.5	1.0*	500		50	50	420	6	5/6	39
BD139-6	TO-126	80	80	5	100	40 160	50 2	0.5	1.0*	500		50	50				39
BD139-10	TO-126	80	80	5	100	25 500	500 2	0.5	1.0*	500		50	50				39
BD140	TO-126	80	80	5	100	40 160	50 2	0.5	1.0*	500		50	50	420	6	5/6	79
BD157	TO-126	250	250		100 μA	30 240	50 10										36
BD158	TO-126	300	300		100 μA	30 240	50 10										36
BD159	TO-126	350	350		100 μA	30 240	50 10										36
BD185	TO-126	30	30		100 μA	40 500	2 2A 2	1.0	1.2*	2A							4F
BD186	TO-126	30	30		100 μA	40 500	2 2A 2	1.0	1.5*	2A							5F
BD187	TO-126	45	45		100 μA	40 500	2 2A 2	1.0	1.5*	2A							4F
BD188	TO-126	45	45		100 μA	40 500	2 2A 2	1.0	1.5*	2A							5F
BD189	TO-126	60	60		100 μA	40 500	2 2A 2	1.0	1.5*	2A							4F
BD190	TO-126	60	60		100 μA	40 500	2 2A 2	1.0	1.5*	2A							5F
BD201	TO-220	60	45	5	10 μA	30 30	3A 2	1.0	1.5*	3A		3	300	420	6	5/6	4A
BD202	TO-220	60	45	5	10 μA	30 30	3A 2	1.0	1.5*	3A		3	300	420	6	5/6	5A

F-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB} (V) Min	V _{CE} [*] (V) Min	V _{EB} (V) Min	I _{CB} @ (mA) Max	V _{CE} [*] V _{CB} (V) Min	V _{CE} [*] (V) Min	V _{CE} [*] (V) Min	HFE h _{FE} 1 kHz [*] Min	HFE h _{FE} 1 kHz [*] Max	I _C @ (mA) Min	V _{CE} & V _{CE} (V) 1	V _{CE} (SAT) (V) Max	V _{BE} (SAT) & V _{BE} (ON) (V) Min	I _C (mA) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD203	TO-220	60	60	5					30	30	2	2	1.0		3A	300		3					4A
BD204	TO-220	60	60	5	10 μA	40			30	30	2A	2	1.0	1.5*	3A								5A
BD220	TO-220		70						30	120	500	4	1.0	1.1*	500								4F
BD221	TO-220		40						30	120	1A	4	1.0	1.3*	1A								4F
BD222	TO-220		60						20	80	1.5A	4	1.0	1.5*	1.5A								4F
BD223	TO-220	70							30	120	300	4	1.0	1.1*	500								5F
BD224	TO-220		40						30	120	1A	4	1.0	1.3*	1A								5F
BD225	TO-220		60						20	80	1.5A	4	1.0	1.5*	1.5A								5F
BD233	TO-126	45	45		100 μA	45			25	40	1A	2	0.6	1.3*	1A	250	420	3		420	6	5/6	4F
BD234	TO-126	45	45		100 μA	45			25	40	1A	2	0.6	1.3*	1A	250	420	3		420	6	5/6	5F
BD235	TO-126	60	60		100 μA	60			25	40	1A	2	0.6	1.3*	1A	250	420	3		420	6	5/6	4F
BD236	TO-126	60	60		100 μA	60			25	40	1A	2	0.6	1.3*	1A	250	420	3		420	6	5/6	5F
BD237	TO-126	80	80		100 μA	80			25	40	1A	2	0.6	1.3*	1A	250	420	3		420	6	5/6	4F
BD238	TO-126		80		100 μA	80			25	40	1A	2	0.6	1.3*	1A	250	420	3		420	6	5/6	5F
BD239	TO-220		45		200 μA*	45			15	40	1A	4	0.7	1.3*	1A	200	420	3		420	6	5/6	4F
BD239A	TO-220		60		200 μA*	60			15	40	1A	4	0.7	1.3*	1A	200	420	3		420	6	5/6	4F
BD239B	TO-220		80		200 μA*	80			15	40	1A	4	0.7	1.3*	1A	200	420	3		420	6	5/6	4F
BD239C	TO-220		100		200 μA*	100			15	40	1A	4	0.7	1.3*	1A	200	420	3		420	6	5/6	4F
BD240	TO-220		45		200 μA*	45			15	40	1A	4	0.7	1.3*	1A	200	420	3		420	6	5/6	5F
BD240A	TO-220		60		200 μA*	60			15	40	1A	4	0.7	1.3*	1A	200	420	3		420	6	5/6	5F

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

5

T-33-01

Pro Electron Series

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} * V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} * I _{CB0} @ (mA) Max	V _{CB} (V) Min	H _{FE} h _{FE} @ 1 kHz* Min Max	I _C & V _{CE} (mA) & (V) Min Max	V _{CE} (SAT) (V) Max	V _{BE} (SAT) & V _{BE} (ON) (V) Min Max	I _C (mA) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD240B	TO-220	80	80		200 μA* 80		15 40	1A 4 200 4	0.7	1.3*	1A		3	200	420	6	5/6	5F
BD240C	TO-220	80	100		200 μA* 100		15 40	1A 4 200 4	0.7	1.3*	1A		3	200	420	6	5/6	5F
BD241	TO-220	80	45		200 μA* 45		10 25	3A 4 1A 4	1.3	1.8*	3A		3	500	420	6	5/6	4F
BD241A	TO-220	80	60		200 μA* 60		10 25	3A 4 1A 4	1.3	1.8*	3A		3	500	420	6	5/6	4F
BD241B	TO-220	80	80		200 μA* 80		10 25	3A 4 1A 4	1.3	1.8*	3A		3	500	420	6	5/6	4F
BD241C	TO-220	80	100		200 μA* 100		10 25	3A 4 1A 4	1.3	1.8*	3A		3	500	420	6	5/6	4F
BD242	TO-220	80	45		200 μA* 45		10 25	3A 4 1A 4	1.2	1.8*	3A		3	500	420	6	5/6	5E
BD242A	TO-220	80	60		200 μA* 60		10 25	3A 4 1A 4	1.2	1.8*	3A		3	500	420	6	5/6	5E
BD242B	TO-220	80	80		200 μA* 80		10 25	3A 4 1A 4	1.2	1.8*	3A	3	3	500	420	6	5/6	5E
BD242C	TO-220	80	100		200 μA* 100		10 25	3A 4 1A 4	1.2	1.8*	3A		3	500	420	6	5/6	5E
BD243	TO-220		45		400 μA* 45		30 15	300 4 3A 4					3	500				4A
BD243A	TO-220		60		400 μA* 60		30 15	300 4 3A 4					3	500				4A
BD243B	TO-220		80		400 μA* 80		30 15	300 4 3A 4					3	500				4A
BD243C	TO-220		100		400 μA* 100		30 15	300 4 3A 4					3	500				4A
BD244	TO-220		45		400 μA* 45		30 15	300 4 3A 4										4A
BD244A	TO-220		60		400 μA* 60		30 15	300 4 3A 4										5A
BD244B	TO-220		80		400 μA* 80		30 15	300 4 3A 4			500		3	500				5A
BD244C	TO-220		100		400 μA* 100		30 15	300 4 3A 4			500		3	500				5A
BD344	TO-126	60	60	5	500 60		60 40	50 1 250 1	0.4		200 50	20	50	50				78

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] (V)		V _{BO} (V)	I _{CE} [*] (mA)		HFE		V _{CE(SAT)} & V _{BE(ON)} [*] (V)		C _{ob} (pF)		f _T (MHz)		t _{off} (ns)	NF (dB)	Test Conditions	Process No.
		Min	Max		Min	Max	Min	Max	Min	Max	Min	Max	Min	Max				
BD345	TO-126	60	60	5	500	60	50	1	0.4	200	20	50	50				38	
BD346	TO-220	60	60		10 μA	40	250	200		200	200	4	250				5A	
BD347	TO-220	60	60		10 μA	30	140	2A			200	4	250				4A	
BD348	TO-126	80	80	5	500	60	140	2A	0.5	250	17	50	50				79	
BD349	TO-126	80	80		500	50	250	250	0.5	250	15	50	50				39	
BD370A	TO-237	80	80		100	25	500	2	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370A-10	TO-237 (91)	80	80		100	40	400	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370A-16	TO-237 (91)	80	80		100	63	160	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370A-25	TO-237 (91)	80	80		100	100	250	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370B	TO-237 (91)	80	80		100	160	400	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370B-10	TO-237 (91)	80	80		100	25	500	2	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370B-16	TO-237 (91)	80	80		100	63	160	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370B-25	TO-237 (91)	80	80		100	100	250	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370C	TO-237 (91)	80	80		100	160	400	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370-6	TO-237 (91)	80	80		100	25	500	2	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370C-10	TO-237 (91)	80	80		100	40	400	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370C-16	TO-237 (91)	80	80		100	63	160	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	
BD370C-25	TO-237 (91)	80	80		100	100	250	100	0.7	1.2* 1A	30	50	200	420	6	5/6	78	

T-33-01

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 10V, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

T-33-01

Pro Electron Series

Type No.	Case Style	V _{CE} * V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} * I _{CB0} (mA) Max	V _{CB} (V) Max	HFE h _{FE} @ 1 kHz* Min Max	I _C & V _{CE} (mA) (V) Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)*} (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test. Conditions	Process No.
BD370D	TO-237 (91)	80	100		100	80	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	79
BD370D-6	TO-237 (91)	80	100		100	80	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	79
BD370D-10	TO-237 (91)	80	100		100	80	25 63	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	79
BD371A	TO-237 (91)	80	45		100	45	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371A-10	TO-237 (91)	80	45		100	45	25 63	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371A-16	TO-237 (91)	80	45		100	45	25 100	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371A-25	TO-237 (91)	80	45		100	45	25 180	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371B	TO-237 (91)	80	60		100	60	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371B-10	TO-237 (91)	80	60		100	60	25 63	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371B-16	TO-237 (91)	80	60		100	60	25 100	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371B-25	TO-237 (91)	80	60		100	60	25 160	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371C	TO-237 (91)	80	80		100	80	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371C-6	TO-237 (91)	80	80		100	80	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371C-10	TO-237 (91)	80	80		100	80	25 63	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371C-16	TO-237 (91)	80	80		100	80	25 100	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD371D	TO-237 (91)	80	100		100	100	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	39
BD371D-6	TO-237 (91)	80	100		100	100	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	39
BD371D-10	TO-237 (91)	80	100		100	100	25 63	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	39
BD372A	TO-237 (90)	80	45		100	45	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	78

PRO ELECTRON SERIES (Continued)



T-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CBO} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} [*] I _{CBO} (mA) Max	HFE h _{FE} 1 kHz [*] Min	HFE h _{FE} 1 kHz [*] Max	I _C & V _{CE} (mA) & (V) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz)		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
													Min	Max				
BD372A-10	TO-237 (90)	80	45		100	25	160	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372A-16	TO-237 (90)	80	45		100	63	250	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372A-25	TO-237 (90)	80	45		100	25	400	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372B	TO-237 (90)	80	60		100	25	400	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372B-10	TO-237 (90)	80	60		100	63	160	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372B-16	TO-237 (90)	80	60		100	25	250	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372B-25	TO-237 (90)	80	60		100	160	400	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372C	TO-237 (90)	80	80		100	25	400	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372C-6	TO-237 (90)	80	80		100	40	100	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372C-10	TO-237 (90)	80	80		100	25	160	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372C-16	TO-237 (90)	80	100		100	100	250	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372D	TO-237 (90)	80	100		100	25	400	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372D-6	TO-237 (90)	80	100		100	40	100	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	78
BD372D-10	TO-237 (90)	80	100		100	25	160	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	79
BD373A	TO-237 (90)	80	45		100	25	400	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373A-10	TO-237 (90)	80	45		100	25	160	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373A-16	TO-237 (90)	80	45		100	100	250	500 2 100 1	0.7	1.2*	1A	30	50	200	420	6	5/6	38

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.



Pro Electron Series

Pro Electron Series

T-33-01

Type No.	Case Style	V _{CE(S)} V _{CB0} (V) Min	V _{CEO} (V) Min	V _{EB0} (V) Min	I _{CB0} (mA) Max	I _{CB0} @ V _{CB} (V)	H _{FE} I _{FE} @ 1 kHz Min Max	I _C & V _{CE} (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} * (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD373A-25	TO-237 (90)	80	45		100	45	25 160	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373B	TO-237 (90)	80	80		100	80	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373B-10	TO-237 (90)	80	60		100	80	25 63	500 100	0.7	1.2*	1A	30	50	200	420	6	5/8	38
BD373B-16	TO-237 (90)	80	60		100	60	25 100	500 100	0.7	1.2*	1A	30	50	200	420	6	5/8	38
BD373B-25	TO-237 (90)	80	60		100	60	25 160	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373C	TO-237 (90)	80	80		100	80	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373C-6	TO-237 (90)	80	80		100	80	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373C-10	TO-237 (90)	80	80		100	80	25 63	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373C-16	TO-237 (90)	80	80		100	80	25 100	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	38
BD373D	TO-237 (90)	80	100		100	100	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	39
BD373D-6	TO-237 (90)	80	100		100	100	25 40	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	39
BD373D-10	TO-237 (90)	80	100		100	100	25 63	500 100	0.7	1.2*	1A	30	50	200	420	6	5/6	39
BD375	TO-126	50	45		2 μA	45	20 40	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD375-6	TO-126	50	45		2 μA	45	20 40	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD375-10	TO-126	50	45		2 μA	45	20 63	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD375-16	TO-126	50	45		2 μA	45	20 100	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD375-25	TO-126	50	45		2 μA	45	20 150	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD376	TO-126	50	45		2 μA	45	20 40	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	78
BD376-6	TO-126	50	45		2 μA	45	20 40	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	78

PRO ELECTRON SERIES (Continued)



T-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} ^s V _{CB} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CS} ^s I _{CB0} (mA) Max	HFE h _{FE} 1 kHz ^s Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} ^s (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD376-10	TO-126	50	45		2 μA	20 63	1.0	1.5*	1A	30	50	200	420	6	5/6	78
BD376-16	TO-126	50	45		2 μA	20 100	1.0	1.5*	1A	30	50	200	420	6	5/6	78
BD376-25	TO-126	50	45		2 μA	20 150	1.0	1.5*	1A	30	50	200	420	6	5/6	78
BD377	TO-126	75	60		2 μA	20 40	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD377-6	TO-126	75	60		2 μA	20 40	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD377-10	TO-126	75	60		2 μA	20 63	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD377-16	TO-126	75	60		2 μA	20 100	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD377-25	TO-126	75	60		2 μA	20 150	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD378	TO-126	75	60		2 μA	20 150	1.0	1.5*	1A	30	50	200	420	6	5/6	38
BD378-6	TO-126	75	60		2 μA	20 40	1.0	1.5*	1A	30	50	200	420	6	5/6	78
BD378-10	TO-126	75	60		2 μA	20 63	1.0	1.5*	1A	30	50	200	420	6	5/6	78
BD378-16	TO-126	75	60		2 μA	20 100	1.0	1.5*	1A	30	50	200	420	6	5/6	78
BD378-25	TO-126	75	60		2 μA	20 150	1.0	1.5*	1A	30	50	200	420	6	5/6	78
BD379	TO-126	100	80		2 μA	20 40	1.0	1.5*	1A	30	50	200	420	6	5/6	39
BD379-6	TO-126	100	80		2 μA	20 40	1.0	1.5*	1A	30	50	200	420	6	5/6	39

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CC} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CC} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CC} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

5

Pro Electron Series



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE} [*] I _{CB0} (mA) Max	HFE h _{FE} @ 1 kHz* Min Max	I _C & V _{CE} (mA) (V) Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max	I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BD379-10	TO-126	100	80		2 μA	20 63	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	39
BD379-16	TO-126	100	80		2 μA	20 100	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	39
BD379-25	TO-126	100	80		2 μA	20 150	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	39
BD380	TO-126	100	80		2 μA	20 40	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	79
BD380-6	TO-126	100	80		2 μA	20 40	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	79
BD380-10	TO-126	100	80		2 μA	20 63	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	79
BD380-16	TO-126	100	80		2 μA	20 100	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	79
BD380-25	TO-126	100	80		2 μA	20 150	1A 150	1.0	1.5*	1A	30	50	200	420	6	5/6	79
BD433	TO-126	22†	22	5	100 μA	50 85 40	2A 500 10	0.5	1.1*	2A		3	250	420	6	5/6	4E
BD434	TO-126	22†	22	5	100 μA	50 85 40	2A 500 10	0.5	1.1*	2A	30	3	250	420	6	5/6	5E
BD435	TO-126	32†	32	5	100 μA	50 85 40	2A 500 10	0.5	1.1*	2A	30	3	250	420	6	5/6	4E
BD436	TO-126	32†	32	5	100 μA	50 85 40	2A 500 10	0.5	1.1*	2A	30	3	250	420	6	5/6	5E
BD437	TO-126	45†	45	5	100 μA	40 40 30	2A 500 10	0.6	1.2*	2A	30	3	250	420	6	5/6	4E
BD438	TO-126	45†	45	5	100 μA	40 40 30	2A 500 10	0.6	1.2*	2A	30	3	250	420	6	5/6	5E
BD439	TO-126	60†	60	5	100 μA	25 40 20	2A 500 10	0.8	1.5*	2A	30	3	250	420	6	5/6	4E

T-33-01

T-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CS} [*] V _{CB0} (V)		V _{CEO} (V) Min	V _{EBO} (V) Min	I _{CS} [*] I _{CB0} (mA)		V _{CB} (V)	h _{FE} h _{FE} @ 1 kHz [*]		I _C & V _{CE} (mA) (V)	V _{CE(SAT)} & V _{BE(ON)} [*] (V) (V)		I _C (mA)	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) @	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
		Min	Max			Min	Max		Min	Max		Min	Max								
BD440	TO-126	60†		60	5	100 μA	60		25 40 20	2A 500 10	1 1 5	0.8	1.5*	2A	80	3	250	420	6	5/6	5E
BD441	TO-126	80†		80	5	100 μA	80		15 40 15	2A 500 10	1 1 5	0.8	1.5*	2A	30	3	250	420	6	5/6	4E
BD442	TO-126	80†		80	5	100 μA	80		15 40 15	2A 500 10	1 1 5	0.8	1.5*	2A	30	3	250	420	6	5/6	5E
BD533	TO-220	80†		45	5	100 μA	45		25 40 20	2A 500 10	2 2 5	0.8	1.5*	2A	30	3	250	420	6	5/6	4E
BD534	TO-220	80†		45	5	100 μA	45		25 40 20	2A 500 10	2 2 5	0.8	1.5*	2A	30	3	250	420	6	5/6	5E
BD535	TO-220	80†		60	5	100 μA	60		25 40 20	2A 500 10	2 2 5	0.8	1.5*	2A	30	3	250	420	6	5/6	4E
BD536	TO-220	80†		60	5	100 μA	60		25 40 20	2A 500 10	2 2 5	0.8	1.5*	2A	30	3	250	420	6	5/6	5E
BD537	TO-220	80†		80	5	100 μA	80		15 40 15	2A 500 10	2 2 5	0.8	1.5*	2A	30	3	250	420	6	5/6	4E
BD538	TO-220	80†		80	5	100 μA	80		15 40 15	2A 500 10	2 2 5	0.8	1.5*	2A	30	3	250	420	6	5/6	5E
BD633	TO-220	45		45	5	200 μA†	45		25 40	1A 25	2 2	0.6	1.3*	1A	30	3	250	420	6	5/6	4F
BD634	TO-220	45		45	5	200 μA†	45		25 40	1A 25	2 2	0.6	1.3*	1A	30	3	250	420	6	5/6	5F
BD635	TO-220	60		60	5	200 μA†	60		25 40	1A 25	2 2	0.6	1.3*	1A	30	3	250	420	6	5/6	4F

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

5

Pro Electron Series

T-33-01

Pro Electron Series

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{BE0} (V) Min	I _{CE} [*] I _{CB0} @ (mA) Max	V _{CB} (V)	h _{FE} h _{FE} @ 1 kHz [*]		I _C & V _{CE} (V)	V _{CE(SAT)} (V) & V _{BE(ON)} [*] (V)		I _C (mA)	C _{ob} (pF) Max	f _T (MHz)		NF (dB) Max	Test Conditions	Process No.
							Min	Max		Min	Max			Min	Max			
BD636	TO-220	60	60	5	200 μA†	60	25 40	1A 25	2 2	0.6	1.3*	1A	30	3	6	5/6	5F	
BD637	TO-220	100	80	5	200 μA†	100	25 40	1A 25	2 2	0.6	1.3*	1A	30	3	6	5/6	4F	
BD638	TO-220	100	80	5	200 μA†	100	25 40	1A 25	2 2	0.6	1.3	1A	30	3	6	5/6	5F	
BD675	TO-126		45		200 μA	45	750*	1.5A	3	2.5	2.5*	1.5A		1			4J	
BD675A	TO-126		45		200 μA	45	750*	2A	3	2.8	2.5*	2A		1			4J	
BD676	TO-126		45		200 μA	45	750*	1.5A	3V	2.5	2.5*	1.5A		1			5J	
BD676A	TO-126		45		200 μA	45	750*	2A	3V	2.8	2.5*	2A		1			5J	
BD677	TO-126		60		200 μA	60	750*	1.5A	3V	2.5	2.5*	1.5A		1			4J	
BD677A	TO-126		60		200 μA	60	750*	2A	3V	2.8	2.5*	2A		1			4J	
BD678	TO-126		60		200 μA	60	750*	1.5A	3V	2.5	2.5*	1.5A		1			5J	
BD678A	TO-126		60		200 μA	60	750*	2A	3V	2.8	2.5*	2A		1			5J	
BD679	TO-126		80		200 μA	80	750*	1.5A	3V	2.5	2.5*	1.5A		1			5J	
BD679A	TO-126		80		200 μA	80	750*	2A	3V	2.8	2.5*	2A		1			4J	
BD680	TO-126		80		200 μA	80	750*	1.5A	3V	2.5	2.5*	1.5A		1			5J	
BD680A	TO-126		80		200 μA	80	750*	2A	3V	2.8	2.5*	2A		1			4J	
BD681	TO-126		100		200 μA	100	750*	1.5A	3V	2.5	2.5*	1.5A		1			5J	
BD682	TO-126		100		200 μA	100	750*	2A	3V	2.8	2.5*	2A		1			4J	
BD733	TO-220	25	25	5	200 μA†	25	50 40	2A 20	1 4	0.6	1.1*	2A		1			4F	
BD734	TO-220	25	25	5	200 μA†	25	50 40	2A 20	1 4	0.6	1.1*	2A		1			5E	
BD735	TO-220	35	35	5	200 μA†	35	40 40	2A 20	1 4	0.6	1.1*	2A		1			4F	
BD736	TO-220	35	35	5	200 μA†	35	40 40	2A 20	1 4	0.6	1.1*	2A		1			5E	
BD737	TO-220	45	45	5	200 μA†	45	40 40	2A 20	1 4	0.8	1.1*	2A		1			4F	
BD738	TO-220	45	45	5	200 μA†	45	40 40	2A 20	1 4	0.8	1.1*	2A		1			5E	
BD795	TO-220		45		100	45	40 25	1A 3A	2 2	1.0	1.6*	3A	3	3			4E	
BD796	TO-220		45		100	45	40 25	1A 3A	2 2	1.0	1.6*	2A	3	3			5E	
BD797	TO-220		60		100 μA	60	40 25	1A 3A	2 2	1.0	1.6*	3A	3	3			4E	

T-33-01

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE5} [*] (V) Min	V _{BE0} (V) Min	I _{CS} [*] (mA) Max	I _{CB} [*] (V)	h _{FE} 1 kHz [*] Min Max	I _C & V _{CE} (mA) (V)	V _{CE(SAT)} (V) & V _{BE(ON)} [*] (V)		V _{BE(SAT)} (V) & V _{BE(ON)} [*] (V)		I _C (mA)	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA)	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
								Max	Min	Max	Min								
BD798	TO-220	60		100 μA	60	40 25	1A 3A	2 2	1.0	1.6*	3A			3	250				5E
BD799	TO-220	80		100 μA	80	30 15	1A 3A	2 2	1.0	1.6*	3A			3	250				4E
BD800	TO-220	80		100 μA	80	30 15	1A 3A	2 2	1.0	1.6*	3A			3	250				5E
BD801	TO-220	100		100 μA	100	30 15	1A 3A	2 2	1.0	1.6*	3A			3	250				4E
BD802	TO-220	100		100 μA	100	30 15	1A 3A	2 2	1.0	1.6*	3A			3	250				5E
BD895	TO-220	45		200 μA	45	750	3A	3		2.5*	3A			1	3A				4K
BD895A	TO-220	45		200 μA	45	750	4A	3		2.5*	4A			1	3A				4K
BD896	TO-220	45		200 μA	45	750	3A	3		2.5*	3A			1	3A				5K
BD896A	TO-220	45		200 μA	45	750	4A	3		2.5*	4A			1	3A				5K
BD897	TO-220	60		200 μA	60	750	3A	3		2.5*	3A			1	3A				4K
BD897A	TO-220	60		200 μA	60	750	4A	3		2.5*	4A			1	4A				4K
BD898	TO-220	60		200 μA	60	750	3A	3		2.5*	3A			1	3A				5K
BD898A	TO-220	60		200 μA	60	750	4A	3		2.5*	4A			1	4A				5K
BD899	TO-220	80		200 μA	80	750	3A	3		2.5*	3A			1	3A				4K
BD899A	TO-220	80		200 μA	80	750	4A	3		2.5*	4A			1	4A				4K
BD900	TO-220	80		200 μA	80	750	3A	3		2.5*	3A			1	3A				5K
BD900A	TO-220	80		200 μA	80	750	4A	3		2.5*	4A			1	4A				5K
BD901	TO-220	100		200 μA	100	750	3A	3		2.5*	3A			1	3A				4K
BD902	TO-220	100		200 μA	100	750	4A	3		2.5*	4A			1	4A				4K
BDX33	TO-220	45		1 mA	45	750	4A	3		2.5*	4A			20	1A				4K
BDX33A	TO-220	60		1 mA	60	750	4A	3		2.5*	4A			20	1A				4K
BDX33B	TO-220	80		1 mA	80	750	3A	3		2.5*	3A			20	1A				4K
BDX33C	TO-220	100		1 mA	100	750	3A	3		2.5*	3A			20	1A				4K
BDX33D	TO-220	120		1 mA	120	750	3A	3		2.5*	3A			20	1A				4K
BDX34	TO-220	45		1 mA	45	750	4A	3		2.5*	4A			20	1A				5K
BDX34A	TO-220	60		1 mA	60	750	4A	3		2.5*	4A			20	1A				5K
BDX34B	TO-220	80		1 mA	80	750	3A	3		2.5*	3A			20	1A				5K

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = 100 kHz.

Pro Electron Series

5

7-31-01

Pro Electron Series

PRO ELECTRON SERIES (Continued)



Type No.	Case Style	V _{CE} * V _{CB} (V) Min	V _{CE} (V) Min	V _{EB} (V) Min	I _{CB} * I _{CB} (mA) Max	V _{CB} (V)	HFE I _h 1 kHz* Min Max	I _C & V _{CE} (mA) (V)	V _{CE} (SAT) (V) Max	V _{BE} (SAT) & V _{BE} (ON)* (V) Min Max	I _C (mA)	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA)	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.	
BDX34C	TO-220		100		1 mA	100	750	3A 3		2.5* 3A	3A		20	1A				5K	
BDX34D	TO-220		120		1 mA	120	750	3A 3		2.5* 3A	3A		20	1A				5K	
BF167	TO-72 (28)	40	30	4	100†	30	26	4 10		0.94* 4								45	
BF180	TO-72 (25)	30	20	3	100	20	13 6	2 10 7										41	
BF181	TO-72 (25)	30	20	3	100	20	13 6	2 10 7										41	
BF194	TO-92 (98)		Same as BF254, see page 5-33 for explanation																
BF195	TO-92 (98)		Same as BF255, see page 5-33 for explanation																
BF196	TO-92 (98)		Same as BF198, see below for explanation																
BF197	TO-92 (98)		Same as BF199, see below for explanation																
BF198	TO-92 (98)	40	30	4	100	40	26 6	4 10 7		0.85* 4								45	
BF199	TO-92 (98)	40	25	4	100	40	36 6	7 10 7					1100 typ	7				47	
BF200	TO-72 (25)	30	20	3	100	40	15 6	3 10 7										41	
BF233-2	TO-92 (96)	30	30	4	100	10	40 6	1 10 7		0.65 0.74* 1		1.0	150	1				49	
BF233-3	TO-92 (96)	30	30	4	100	10	60 6	10 7		0.65 0.74* 1		1.0	150	1				49	
BF233-4	TO-92 (96)	30	30	4	100	10	90 6	1 10 7		0.65 0.74* 1		1.0	150	1				49	
BF233-5	TO-92 (96)	30	30	4	100	10	140 6	220 7		0.65 0.74* 1		1.0	150	1				49	
BF237	TO-92 (98)	45	30	4	100	20			0.25		10							47	
BF238	TO-92 (98)	45	30	4	100	20			0.25		10							47	
BF240	TO-92 (98)	40	40	4	10Q	20	67 6	222 7		0.65 0.74* 1		0.34		1		3.5	7	47	
BF241	TO-92 (98)	40	40	4	100	20	36 6	125 7		0.65 0.74* 1		0.34		1		3.5	7	47	

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE5} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CE5} [*] I _{CB0} (mA) Max	H _{FE} h _{FE} @ 1 kHz [*] Min Max	I _C (mA) & V _{CE} (V) Min Max	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V) Min Max	C _{ob} (pF) Max	f _T (MHz) Min Max	I _C (mA) @ Min Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BF254	TO-92 (98)	30	20	5	100	20	1 10	0.65 0.74* 1	0.34			1		3.5	7	46
BF255	TO-92 (98)	30	20	-5	100	20	1 10	0.65 0.74* 1	0.34			1		3.5	7	46
BF257	TO-39	100	100	5	50	100	30 10	1.0 0.65 0.74* 30	0.34			1		3.5	7	48
BF258	TO-39	250	250	5	50	200	30 10	1.0 0.65 0.74* 30	0.34			1		3.5	7	48
BF259	TO-39	300	300	5	50	250	30 10	1.0 0.65 0.74* 30	0.34			1		3.5	7	48
BF457	TO-126	100	100	5	50	100	30 10	1.0 0.65 0.74* 30	0.34			1		3.5	7	48
BF458	TO-126	250	200	5	50	200	30 10	1.0 0.65 0.74* 30	0.34			1		3.5	7	48
BF459	TO-126	300	300	5	50	250	30 10	1.0 0.65 0.74* 30	0.34			1		3.5	7	48
BFX13	TO-18	20	15	5	50	15	100 2	0.2 0.78 1	6	150	10			10	8	66
BFX29	TO-5	20	15	5	50	50	50 250 10 0.35	0.25 0.7 0.9 10	.12	100	50	150			9	63
BFX30	TO-5	65	65	5	50	50	150 10 0.4	0.4 1.3 150	12				290		4	63
BFX37	TO-18	60	60	6	20†	50	100 10 5	0.4 1.0 50	6	40	0.5			3	1	62
BFX65	TO-18	45	45	6	10*	40	100 10 5	0.25 0.9 10	6.5					3	1	62

T-31-01

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series

5

T-31-01

Pro Electron Series



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Max	V _{EB0} (V) Min	V _{EB0} (V) Max	I _{CB0} @ V _{CB} (mA) Max	HFE h _{FE} 1 kHz [*] Min	HFE h _{FE} 1 kHz [*] Max	I _C & V _{CE} (mA) & (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} (V) Min	I _C @ V _{BE(ON)} (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	f _T (MHz) Max	I _C @ f _T (mA)	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
BFX84	TO-39	45	500	6	100	500	15	20	1A 500 10	0.15	1.2	10	12	50	360	50	360		9	14
BFX85	TO-39	45	500	6	80	500	15	30	1A 500 10	0.15	1.2	10	12	50	360	50	360		9	14
BFX86	TO-39	45	500	6	30	500	15	30	1A 500 10	0.15	1.2	10	12	50	360	50	360		9	14
BFX87	TO-5	45	500	6	40	500	25	40	500 150 10	0.4	1.3	150	12	100	150	50	150		9	63
BFX88	TO-5	45	500	6	30	500	25	40	500 150 10	0.4	1.3	150	12	100	150	50	150		9	63
BFY39	TO-18	45	500	5	30	500	35	40	10 500 10	1.0	1.0	10		150	10	10				23
BFY39-1	TO-18	45	500	5	30	500	35	40	10 500 10	1.0	1.0	10		150	10	10				23
BFY39-2	TO-18	45	500	5	30	500	100	200	10 500 10	1.0	1.0	10		150	10	10				23
BFY39-3	TO-18	45	500	5	30	500	180	400	10 500 10	1.0	1.0	10		150	10	10				23
BFY50	TO-18	80	500	6	80	500	20	30	10 500 10	0.1	1.2	10	12	60	360	50	360		9	14
BFY51	TO-39	60	500	6	60	500	30	40	10 500 10	0.1	1.2	10	12	60	360	50	360		9	14
BFY52	TO-39	40	500	6	60	500	30	40	10 500 10	0.1	1.2	10	12	60	360	50	360		9	14
BFY56	TO-39	80	500	5	50	500	15	20	10 500 10	0.3	1.5	150	25	40	50	50				14

PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE} [*] V _{CB0} (V) Min	V _{CE0} (V) Min	V _{EB0} (V) Min	I _{CB0} [*] (mA) Max	HFE		I _C & V _{CE} (mA) & (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V)		I _C (mA)	C _{ob} (pF) Max	f _T (MHz)		t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.
						Min	Max			Min	Max			Min	Max				
BFY72	TO-39	50	28	5	40*	20	15 20 30 40 15	0.1 1 10 10 500 10	0.25	1.2	150	8	50	50					19
BFY76	TO-18	45	45	6	20	30	30 80 140	0.01 0.5 5 5	0.35	1.6	500	6							
BSX21	TO-18		80		500	50	20	4		0.9	4		60	4					07
BSX45-6	TO-39	80*	40	7	10*	60	40	100	1.0	2.0	500	20	60	50					14
BSX45-10	TO-39	80*	40	7	10*	60	63	160	1.0	2.0	500	20	60	50					14
BSX45-16	TO-39	80*	40	7	10*	60	100	250	1.0	2.0	500	20	60	50					14
BSX46-6	TO-39	100*	60	7	10*	60	40	100	1.0	2.0	500	25	60	50					12
BSX46-10	TO-39	100*	60	7	10*	60	63	160	1.0	2.0	500	25	60	50					12
BSX46-16	TO-39	100*	60	7	10*	60	100	250	1.0	2.0	500	25	60	50					12
BSX48	TO-18	50	25	5	120	50	17	100	1.5	1.5	500	6	250	30					19
BSX88	TO-18	40	15	5	25	20	15	0.5	0.5	0.72	10	6	300	10					21
BSY38	TO-18	20	12	5	100	20	30	10	0.25	0.7	0.85	5	200	10			16		21
BSY39	TO-18	20	12	5	100	20	15	45	0.6	1.5	100	5	200	10			45		21
BSY51	TO-18	60	35	5	100	30	40	120	0.25	0.7	0.85	5	200	10			45		21
BSY52	TO-18	60	25	5	100	30	20	70	0.6	1.5	100	9	130	50					19
BSY53	TO-18	75	30	7	10	60	20	10	0.6	1.3	150	9	130	50					19
							35	10	0.6	1.3	150	9	150	50					19
							40	150	2.0	1.3	500	10	500	10					19

T-31-01

TEST CONDITIONS: (1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CE} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CE} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CE} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CE} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

Pro Electron Series



PRO ELECTRON SERIES (Continued)

Type No.	Case Style	V _{CE0} [*] (V) Min	V _{CE0} [*] (V) Min	V _{BE0} (V) Min	I _{CE0} [*] (mA) Max	I _{CB0} [*] (mA) Max	V _{CB} (V)	HFE h _{FE} 1 kHz [*]		I _C & V _{CE} (mA) (V)	V _{CE(SAT)} (V) Max	V _{BE(SAT)} & V _{BE(ON)} [*] (V)		I _C (mA) Max	C _{ob} (pF) Max	f _T (MHz) Min	I _C (mA) Max	t _{off} (ns) Max	NF (dB) Max	Test Conditions	Process No.	
								Min	Max			Min	Max									
BSY54	TO-18	30	7	60	10	10	10	35	0.1	10	0.6	1.3	150	9	150	50	19					
								75	10	10												
BSY95A	TO-18	15	5	16	50	10	10	30	1	0.35	0.35	0.67	200	6	200	10	21					
								50	10	0.35												

TEST CONDITIONS:

(1) I_C = 200 μA, V_{CE} = 5V, f = 1 kHz. (2) I_C = 100 mA, V_{CC} = 20V, I_B¹ = I_B² = 5 mA. (3) I_C = 200 μA, V_{CE} = 2V, f = 1 kHz. (4) I_C = 100 mA, V_{CC} = 10V, I_B¹ = I_B² = 10 mA. (5) I_C = 10 mA, V_{CC} = 3V, I_B¹ = I_B² = 1 mA. (6) I_C = 100 μA, V_{CE} = 5V, f = 1 kHz. (7) I_C = 1 mA, V_{CE} = 10V, f = 200 kHz. (8) I_C = 1 mA, V_{CE} = 5V, f = 1 kHz. (9) I_C = 150 mA, V_{CC} = 6V, I_B¹ = I_B² = 15 mA. (10) I_C = 10 μA, V_{CE} = 5V, f = WB.

T-31-01

6501130 NATL SEMICOND, (DISCRETE)

28C 35546

T-31-01

Pro Electron Series

PRO ELECTRON SERIES (JFET)



Type No.	Case Style	BV _{GSD} (V) @ I _G	I _{GSS} I _{PGD} (nA) @ V _{GD}	V _P @ V _{DS} (V)		V _{GS} (V) @ V _{GS} (V)		I _D (nA)	I _D (μA)	I _{DSS} (mA) @ V _{DS} (V)		R _e (YFS) (mmho) @ f (MHz)		C _{iss} (pF) @ V _{DS} (V)		V _{GS} (V)	C _{rss} (pF) @ V _{DS} (V)	V _{GS} (V)	NF (dB) @ R _G = 1k Ω, f (Hz)*	Process No.	Pkg. No.	
				Min	Max	Min	Max			Min	Max	Min	Max	Min	Max							Typ
BF244A	TO-92	30	1	5	20	.5	8	15	10	2	6.5	15	3	6.5	.001	4	20	-1	1.1	20	50	74
BF244B	TO-92	30	1	5	20	.5	8	15	10	6	15	15	3	6.5	.001	4	20	-1	1.1	20	50	74
BF244C	TO-92	30	1	5	20	.5	8	15	10	12	25	15	3	6.5	.001	4	20	-1	1.1	20	50	74
BF245A	TO-92	30	1	5	20	.5	8	15	10	2	6.5	15	3	6.5	.001	4	20	-1	1.1	20	50	77
BF245B	TO-92	30	1	5	20	.5	8	15	10	6	15	15	3	6.5	.001	4	20	-1	1.1	20	50	77
BF245C	TO-92	30	1	5	20	.5	8	15	10	12	25	15	3	6.5	.001	4	20	-1	1.1	20	50	77
BF246A	TO-92	25	1	5	15	.6	14.5	15	10	30	80	15	8	.001	11	15	0	3.5	15	0	51	74
BF246B	TO-92	25	1	5	15	.6	14.5	15	10	60	140	15	8	.001	11	15	0	3.5	15	0	51	74
BF246C	TO-92	25	1	5	15	.6	14.5	15	10	110	250	15	8	.001	11	15	0	3.5	15	0	51	74
BF247A	TO-92	25	1	5	15	.6	14.5	15	10	30	80	15	8	.001	11	15	0	3.5	15	0	51	77
BF247B	TO-92	25	1	5	15	.6	14.5	15	10	60	140	15	8	.001	11	15	0	3.5	15	0	51	77
BF247C	TO-92	25	1	5	15	.6	14.5	15	10	110	250	15	8	.001	11	15	0	3.5	15	0	51	77
BF256A	TO-92	30	1	5	20	.5	7.5	15	200	3	7	15	4.5	.001	.7	20	-1	.7	20	800	50	77
BF256B	TO-92	30	1	5	20	.5	7.5	15	200	6	13	15	4.5	.001	.7	20	-1	.7	20	800	50	77
BF256C	TO-92	30	1	5	20	.5	7.5	15	200	11	18	15	4.5	.001	.7	20	-1	.7	20	800	50	77
BC264A	TO-92	30	1	10	20	.5	15	15	10	2	4.5	15	2.5	.001	4.0	15	-1	1.2	15	40*	50	77
BC264B	TO-92	30	1	10	20	.5	15	15	10	3.5	6.5	15	3.0	.001	4.0	15	-1	1.2	15	40*	50	77
BC264C	TO-92	30	1	10	20	.5	15	15	10	5.0	8.0	15	3.5	.001	4.0	15	-1	1.2	15	40*	50	77
BC264D	TO-92	30	1	10	20	.5	15	15	10	7.0	12.0	15	4.0	.001	4.0	15	-1	1.2	15	40*	50	77

5